Se	arcn	Notes	

Application/Control	No.	

10/813,383 Examiner

Stacy B. Chen

Applicant(s)/Patent under Reexamination

DAVEY ET AL.

Art Unit

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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
uspat, uspgpub, epo, jpo, derwent, medline, embase, biosis; see search history in file	10/28/2005	SF
PALM/EAST inventorship; updated	6/20/2006	SBC
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